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We investigated singlet exciton diffusion in three **ITIC** derivatives used as electron acceptors in organic photovoltaics (OPVs) by time-resolved photoluminescence volume quenching and exciton-exciton annihilation. The exciton diffusion coefficient was found to be in the range of $0.003\text{--}0.007\text{ cm}^2\text{ s}^{-1}$ which leads to a three-dimensional exciton diffusion length of up to 31 nm. We fabricated solar cells using bulk heterojunctions of these acceptors with the electron donor **PTB7-Th** which showed $\sim 7\%$ efficiency and large scale phase separation. Our results show that long range exciton diffusion and large domains offer significant advantages for OPVs.

The use of abundant and clean solar power to generate electricity is a very promising direction for renewable power. Organic photovoltaics (OPVs) are expected to play a major role in future power generation because of their simple fabrication enabling the deposition of solar cells on flexible substrates by printing from solution or spray-coating. Recently, the development of non-fullerene electron acceptors (NFAs), which replace fullerene derivatives, has led to important advances in both efficiency and stability.^{1,2} In contrast to fullerene derivatives, the absorption of NFAs extends over the visible spectral range and so improves light harvesting. The ionisation potentials and electron affinities of NFAs can be adjusted to achieve lower losses of open-circuit voltage (V_{oc}).^{1,3} Organic solar cells using NFAs in binary and ternary blends to form bulk heterojunctions (BHJ) have reached power conversion efficiencies (PCE) of more than 17%.^{4,5} The use of NFAs also significantly increases the stability of solar cells with projected lifetimes up to 20 years.⁶

With high efficiency and other desirable properties such as light weight, low production cost, tuneable bandgaps and

mechanical flexibility, OPVs offer low energy payback time compared to other photovoltaic technologies such as commercially available silicon. The energy payback time of OPVs with PCEs of 15% is predicted to be 0.5 weeks compared to 0.5 years for silicon.⁷ The bandgap tuneability of NFAs has led to the development of near-infrared absorbers⁸ which enable the production of semi-transparent or even fully transparent cells for their possible integration into buildings.⁹ Furthermore, OPVs are made from “green” materials compared to other solution or spray coated photovoltaic materials such as lead-containing hybrid perovskites.

The length-scale of phase separation between donor and acceptor is an important consideration in BHJ solar cells. Large scale phase separation is helpful for efficient charge extraction, as it reduces the area of the BHJ and so reduces charge recombination losses.¹⁰ However, this needs to be balanced against the need for efficient exciton harvesting (charge generation), which requires that the length-scale of phase separation should be comparable to the exciton diffusion length (L_D) which is typically less than 10 nm in many solution-processed OPV materials.^{10,11} Increasing exciton diffusion length is very desirable because it provides a way of overcoming this trade-off by enabling efficient exciton harvesting in larger domains.

BHJs made from NFAs have shown large donor and acceptor domains (20–50 nm) and high domain purity.¹² Despite these large domains, efficient exciton dissociation is observed in BHJs with NFAs which suggests that exciton diffusion lengths in NFAs are on a length-scale comparable to these domains. Despite the rapid development of materials and device engineering, photophysical investigations of NFAs are less developed, with only a couple of reports of measurements of exciton diffusion in NFAs (abbreviated names **IDIC**, **INIC** and its fluorinated derivative **FINIC**) using exciton-exciton annihilation measurements.^{13,14}

Here we investigated exciton diffusion in a family of efficient NFA materials shown in Fig. 1 (abbreviated names **ITIC**,¹⁵ **ITIC-Th**¹⁶ and **IT-4F**¹⁷). Time-resolved photoluminescence (PL) volume quenching and exciton-exciton annihilation

^aOrganic Semiconductor Centre, SUPA, School of Physics and Astronomy, University of St Andrews, St. Andrews, KY16 9SS, UK. E-mail: idws@st-andrews.ac.uk

^bLondon Centre for Energy Engineering, School of Engineering, London South Bank University, 103 Borough Rd, London, SE1 0AA, UK. E-mail: sajadt@lsbu.ac.uk

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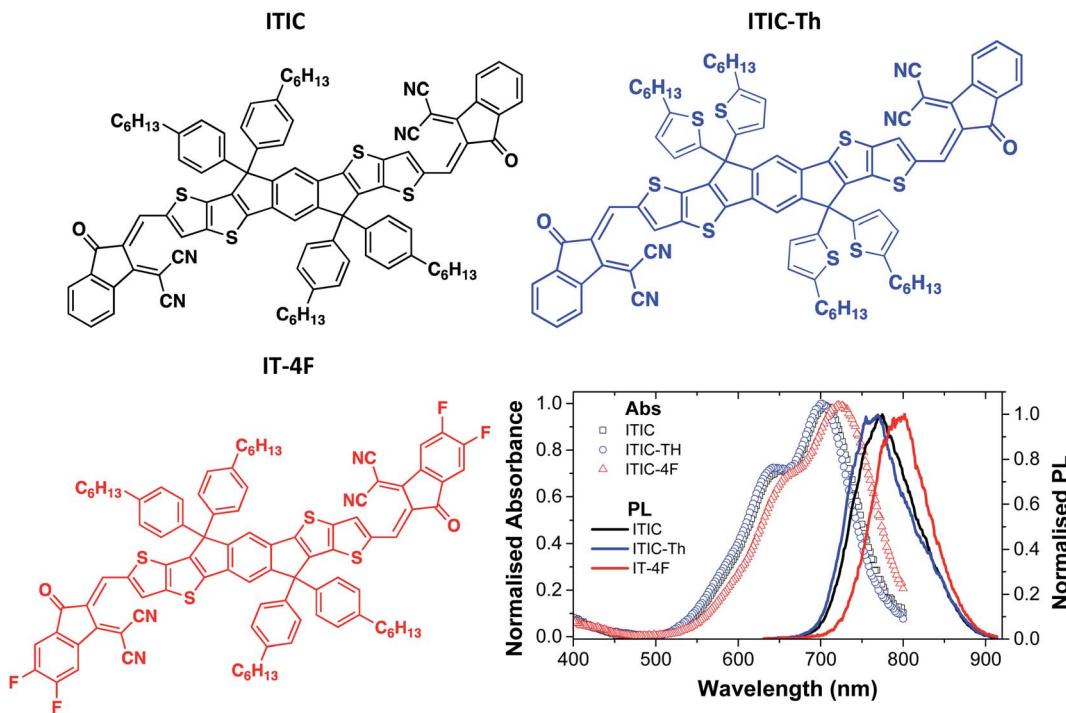


Fig. 1 Chemical structures of ITIC derivatives used in this study and their absorption and photoluminescence (PL) spectra.

measurements gave consistent values of exciton diffusion coefficient in all three materials investigated, which leads to three-dimensional exciton diffusion lengths between 18 and 31 nm. We fabricated solar cells using blends of these NFAs with the widely used donor polymer **PTB7-Th** which showed PCEs of more than 7%, consistent with previous reports.^{15,18} The analysis of PL decays measured in these photovoltaic blends suggests large and pure NFA domains of up to 32 nm in diameter.

Absorption and PL spectra of neat films of the three electron acceptors studied are shown in Fig. 1. **ITIC** has an absorption peak around 707 nm which corresponds to a 0–0 vibronic transition and a shoulder around 642 nm which can be attributed to a vibronic 0–1 transition. The absorption of **ITIC-Th** is slightly blue-shifted compared to **ITIC** with a strong 0–0 peak at around 703 nm whilst absorption of **IT-4F** is red-shifted with a 0–0 peak around 723 nm and a 0–1 shoulder around 659 nm. All these molecules show a single emission peak in thin films: **ITIC** emits around 772 nm, **ITIC-Th** around 763 nm and **IT-4F** around 795 nm.

First we investigated singlet exciton diffusion in films of these electron acceptors using PL quenching by **DR3TBDTT** molecules dispersed at low concentrations in the volume of electron acceptor films. The resulting fluorescence decays are plotted in Fig. S1.[†] For accurate measurement of exciton diffusion, homogenous dispersion of the quencher is required. To check this, we measured a range of quencher concentrations and determine the rate of quenching for each concentration (as shown in Fig. S2[†]). The rate of quenching shows a linear dependence at low concentration of quencher and deviates

from the linear regime at high concentration. For exciton diffusion measurement, we only use the linear regime.

At low concentration, PL quenching is controlled by exciton diffusion to the quencher. For a given concentration, PL will decay faster if exciton diffusion is faster, so the decay can be used to measure exciton diffusion. As there is a finite spectral overlap of the PL spectra of the studied electron acceptors with the absorption of **DR3TBDTT**, therefore, Förster resonance energy transfer (FRET) to dispersed **DR3TBDTT** molecules can occur followed by electron transfer from **DR3TBDTT** to the electron acceptor which results in PL quenching (Fig. 2). For analysis it is convenient to take a ratio of the PL decay in films with a quencher to the PL decay without a quencher to account for the natural exciton decay in neat electron acceptor films. At high concentrations of dispersed **DR3TBDTT** molecules the direct FRET to the quencher dominates and the natural logarithm of the PL ratio is proportional to the square root of time as explained in ESI and has been observed before.^{19,20} This allows us to estimate the Förster radius R_0 for FRET from electron acceptors to **DR3TBDTT**.

After determining R_0 , the diffusion coefficient is fitted to the PL decays (Fig. 2d) using the formula developed by Gösele *et al.* for the case of diffusion mediated FRET to quenchers^{21,22} as described further in ESI.[†] From this fitting we obtain exciton diffusion coefficients of $(3.4 \pm 0.8) \times 10^{-3} \text{ cm}^2 \text{ s}^{-1}$ for **ITIC**, $(7.0 \pm 2.0) \times 10^{-3} \text{ cm}^2 \text{ s}^{-1}$ for **ITIC-Th** and $(4.5 \pm 0.8) \times 10^{-3} \text{ cm}^2 \text{ s}^{-1}$ for **IT-4F**.

To verify these results we investigated exciton diffusion using singlet–singlet exciton annihilation. Excitons diffuse in the films and when two excitons approach each other one exciton transfers its energy onto the other which goes into



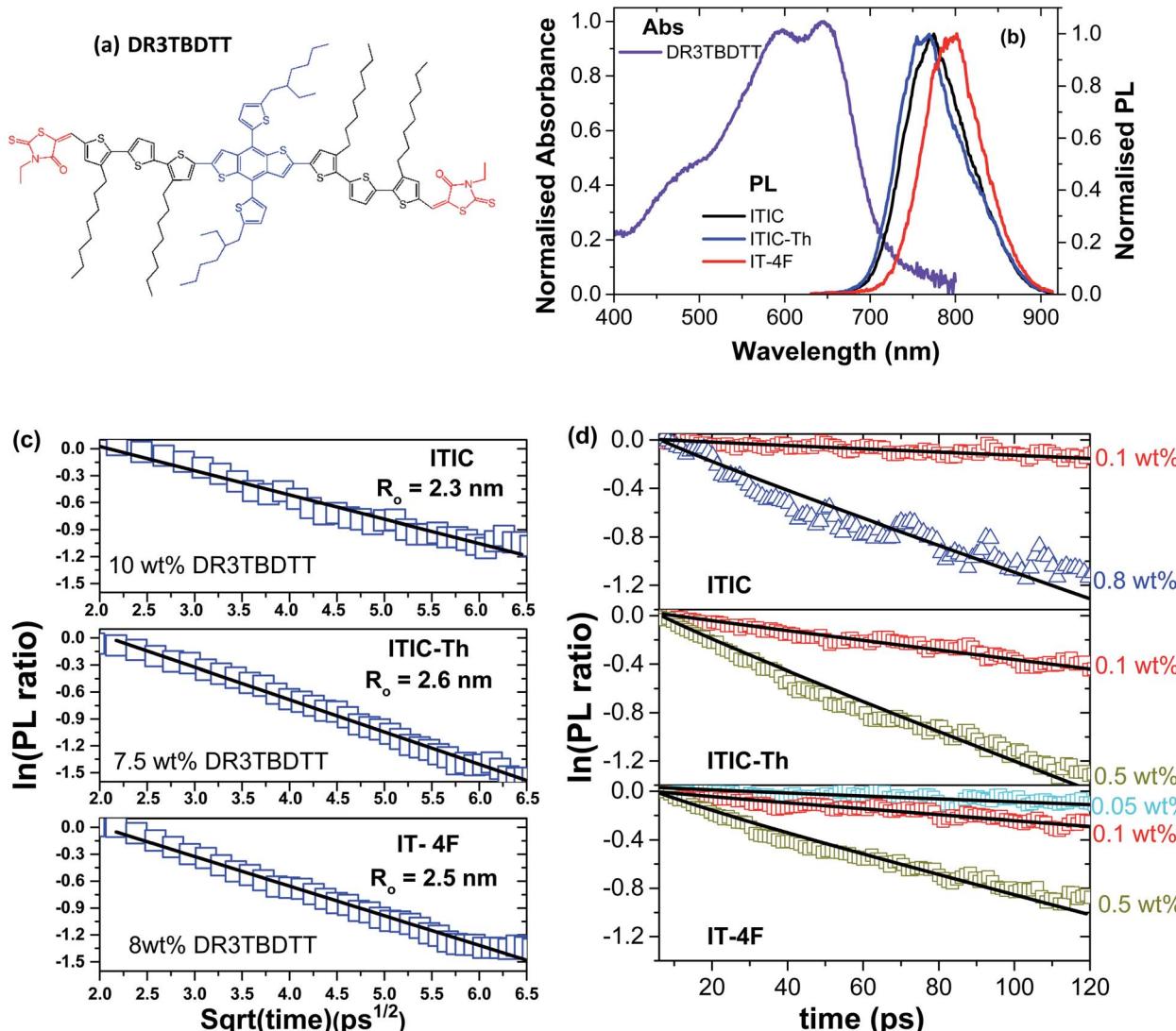


Fig. 2 (a) Chemical structure of DR3TBDTT molecule used as a dispersed volume quencher of PL in NFA films. (b) Absorption spectrum of a neat DR3TBDTT film spin-coated from chlorobenzene solution and photoluminescence spectra of neat NFA films. (c and d) The natural logarithm of the ratio of the PL decays in films of ITIC derivatives doped with different concentrations of the quencher to the PL of the neat films without a quencher plotted vs. square root of time (c) and on a linear time axis (d). The lines are the fits with a sum of quenching rates representing direct Förster resonance energy transfer to the quencher (FRET) and diffusion-mediated quenching with the Förster radius R_0 and diffusion coefficient D as fitting parameters (details described in ESI†).

a higher excited state. The higher energy state usually relaxes to the lowest excited state and one exciton is lost per annihilation event. We used time-resolved PL measured at different initial excitation densities to study this process and the results are shown in Fig. 3. PL intensity is proportional to the density of singlet excitons N and described by the rate equation

$$\frac{dN}{dt} = G - kN - \gamma N^2 \quad (1)$$

Here G is the generation rate which in our case is instantaneous (*i.e.* within the duration of the excitation pulse of 200 fs), k is the natural decay rate constant in the absence of annihilation and γ is the annihilation constant. In order to determine k we measured the PL decays using very low excitation density ($< 10^{15} \text{ cm}^{-3}$) which is two orders of magnitude lower than the

densities at which exciton-exciton annihilation is observed (Fig. S3†). Then we fitted the PL decay at this low excitation density with a sum of two exponential functions (Fig. S4 and Table S1 in ESI†) and used it to solve eqn (1) numerically and model the PL decays at high excitation densities with the annihilation constant γ as a fitting parameter. The best fits were obtained with values of $\gamma = (1.0 \pm 0.2) \times 10^{-8} \text{ cm}^3 \text{ s}^{-1}$ for **ITIC**, $\gamma = (1.0 \pm 0.2) \times 10^{-8} \text{ cm}^3 \text{ s}^{-1}$ for **IT-4F** and $\gamma = (1.4 \pm 0.3) \times 10^{-8} \text{ cm}^3 \text{ s}^{-1}$ for **ITIC-Th**. These results are summarised in Table 1. The γ values are among the highest reported in organic semiconductors.^{23–27} Although a substantially higher value $\gamma = 2.5 \times 10^{-7} \text{ cm}^3 \text{ s}^{-1}$ has been reported in the non-fullerene acceptor IDIC,¹³ the authors of this report did not reach annihilation-free conditions and so used the excited-state

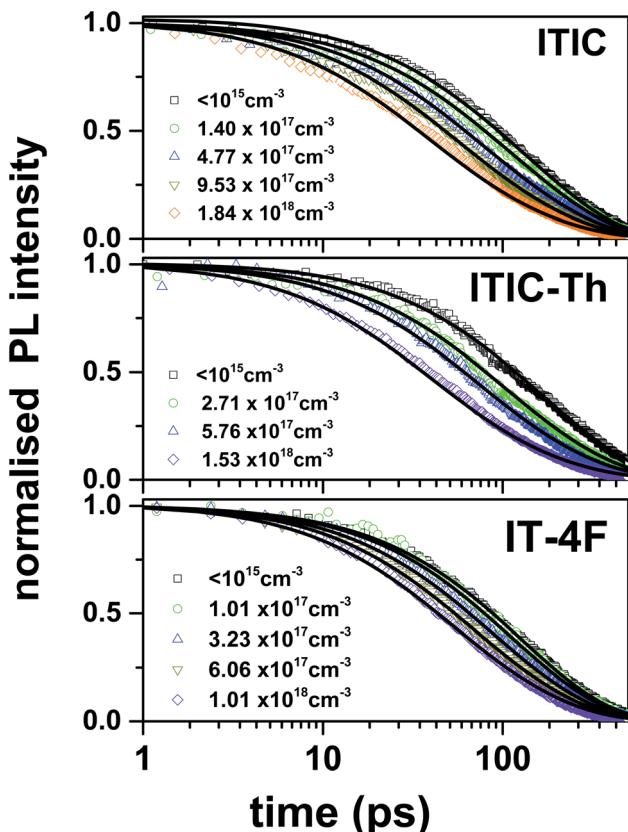


Fig. 3 Singlet–singlet annihilation measurements showing PL decays in neat films of ITIC derivatives measured at different initial excitation densities given in the legend. Solid lines are the numerical fits using eqn (1) with a time-independent γ as a fitting parameter given in Table 1.

lifetime of IDIC diluted in a polystyrene matrix as a reference. Since the exciton decay in a neat film is usually faster than in a matrix, the extracted γ value using too slow a reference decay may be substantially overestimated.

The kinematic model of diffusion-limited exciton–exciton annihilation in unrestricted three-dimensional space relates the annihilation constant γ to the exciton diffusion coefficient D as

$$\gamma = 4\pi DR_a \quad (2)$$

where R_a is the so called annihilation radius.²⁸ Using D values measured by volume quenching we determine R_a values of 2.4 nm, 1.5 nm and 1.8 nm for ITIC, ITIC-Th and IT-4F,

respectively. These values are slightly larger than the d_{100} lamellar spacing but similar to the backbone spacing reported in these materials by grazing-incidence wide-angle X-ray scattering (GIWAXS, see Table 1).^{29,30} The d_{100} spacing is the shortest distance two excitons can approach each other when diffusing along the π – π stacks, hence R_a is expected to be slightly larger than the d_{100} spacing. Based on these considerations the agreement between the two techniques to measure exciton diffusion is very good.

The obtained values of diffusion coefficient are more than an order of magnitude higher than for the widely used fullerene derivative PC₇₁BM ($D = 1.6 \times 10^{-4} \text{ cm}^2 \text{ s}^{-1}$) measured using volume quenching.³¹ It is interesting to note that ITIC-Th has been reported to show about five times higher electron mobility as compared to ITIC and 1.4 times higher than IT-4F³² suggesting a possible correlation between exciton diffusivity and electron mobility. It is very likely that both are enhanced by the large (010) coherence length in ITIC-Th along the π – π stacks up to 4 nm measured using GIWAXS.³³

Normally, the lower value of exciton diffusion coefficient (D) in solution-processed organic semiconductors is associated with energetic disorder that is typically larger than thermal energy at room temperature, thus reducing the available density of states for exciton hopping.^{10,11} In the case of highly disordered materials, dispersive exciton transport is observed where the distribution of energy states has a strong influence on the rate of hopping *i.e.* exciton diffusion will be faster initially while relaxing within the density of states and become slower at longer time due to the unavailability of energetically accessible sites. Experimentally it leads to strong time-dependent PL quenching.³⁴ However, in the case of NFAs, we observed a time-independent rate of PL quenching both in exciton–exciton annihilation (where a single time-independent gamma is used to describe the decay) and volume quenching measurements (at low quencher concentration where exciton diffusion is the dominant process). This indicates that fast exciton diffusion in NFAs is due to their higher energetic and structural order.

The charge generation efficiency depends on the ability of each exciton to reach a heterojunction which in turn depends on the exciton diffusion length and the donor and acceptor domain sizes. In BHJ geometry, three-dimensional exciton diffusion length is relevant, therefore, we estimated the three-dimensional exciton diffusion length using $L_{3D} = \sqrt{6D\tau}$. Here τ is the exciton decay time in the absence of annihilation. The PL decays were non-exponential even for the low excitation density so we took τ to be the time taken for PL to fall to 1/e of its initial value in our estimation of exciton diffusion length. The 1/e

Table 1 Singlet exciton diffusion coefficient D , singlet–singlet annihilation constant γ , annihilation radius R_a , singlet exciton lifetime τ and three-dimensional exciton diffusion length L_{3D} obtained from results in Fig. 2 and 3. The literature values of the lamellar d_{100} spacing reported in these materials by GIWAXS are given for comparison (ref. 29 and 30)

Material	$D (\times 10^{-3} \text{ cm}^2 \text{ s}^{-1})$	$\gamma (\times 10^{-8} \text{ cm}^3 \text{ s}^{-1})$	$R_a (\text{nm})$	$d_{100} (\text{nm})$	$\tau (\text{ps})$	$L_{3D} (\text{nm})$
ITIC	3.4 ± 0.8	1.0 ± 0.2	2.4 ± 0.3	1.50	163 ± 10	18 ± 2
ITIC-Th	7.0 ± 2.0	1.4 ± 0.3	1.5 ± 0.4	1.34	223 ± 10	31 ± 3
IT-4F	4.5 ± 0.8	1.0 ± 0.2	1.8 ± 0.3	1.79	132 ± 10	19 ± 2



decay times were 163 ps for **ITIC**, 223 ps for **ITIC-Th** and 132 ps for **IT-4F**. This leads to values of the three-dimensional diffusion length of 18 ± 2 nm for **ITIC**, 31 ± 3 nm for **ITIC-Th** and 19 ± 2 nm for **IT-4F** (Table 1).

We also measured singlet exciton diffusion in **PTB7-Th** films using PL quenching by dispersed low concentrations of **ITIC** or **IT-4F** molecules. This gives the values of $(1.0 \pm 0.1) \times 10^{-3} \text{ cm}^2 \text{ s}^{-1}$ for exciton diffusion coefficient and 12 nm for the 3D diffusion length in **PTB7-Th** (details are given in ES[†]).

To investigate the effect of exciton diffusion on the photovoltaic device performance, we fabricated solar cells using these NFAs as acceptors. We followed a simple protocol for device fabrication without any extra processing (e.g. thermal or solvent vapor annealing) or additives. For all three NFAs, we used the same donor: acceptor blend weight ratio of 1 : 1.3, (with a total concentration of 23 mg mL⁻¹) for easy comparison between the exciton diffusion length and solar cell device performance. For donor, we selected the widely used polymer **PTB7-Th**, whose molecular structure is shown in Fig. 4a. The photovoltaic *J-V* characteristics are shown in Fig. 4b and the external quantum efficiency (EQE) spectra are shown in Fig. 4c. All the photovoltaic performance parameters are given in Table 2. Our solar cell

efficiencies are comparable to previously reported values using **PTB7-Th** as donor and **ITIC** as acceptor.^{15,18} Though all the three **PTB7-Th:NFA** blends showed power conversion efficiency (PCE) close to 7%, the blend, **PTB7-Th:ITIC-Th** showed the highest average (7%) and champion efficiency of 7.45%. The illuminated current density–voltage curve given in Fig. 4b shows that the blend with **IT-4F** has a higher short circuit current (J_{SC}) density. This is due to enhanced absorption of this molecule in the region between 550 nm and 850 nm compared to the other two as shown in the absorption spectra in Fig. 1. The extended absorption range of this blend, **PTB7-Th:IT-4F**, is further reflected in the EQE spectra shown in Fig. 4c. Overall the blends with these three NFAs show an EQE of more than 70% in the region between 550 nm and 750 nm. The blends **PTB7-Th:ITIC**, and **PTB7-Th:ITIC-Th** show higher open circuit voltage (V_{OC}) of ~ 0.78 V compared to 0.65 V in **IT-4F** due to the wider HOMO–LUMO difference between the donor **PTB7-Th** and the corresponding NFAs (energy levels of NFAs along with **PTB7-Th** are given in the ESI, Fig. S9†). Among the three blends, the OPVs with **PTB7-Th:ITIC-Th** blend showed the highest fill factor (FF) of $\sim 62\%$. To estimate the contribution of reduced recombination to the higher FF of the **PTB7-Th:ITIC-Th** blend compared to

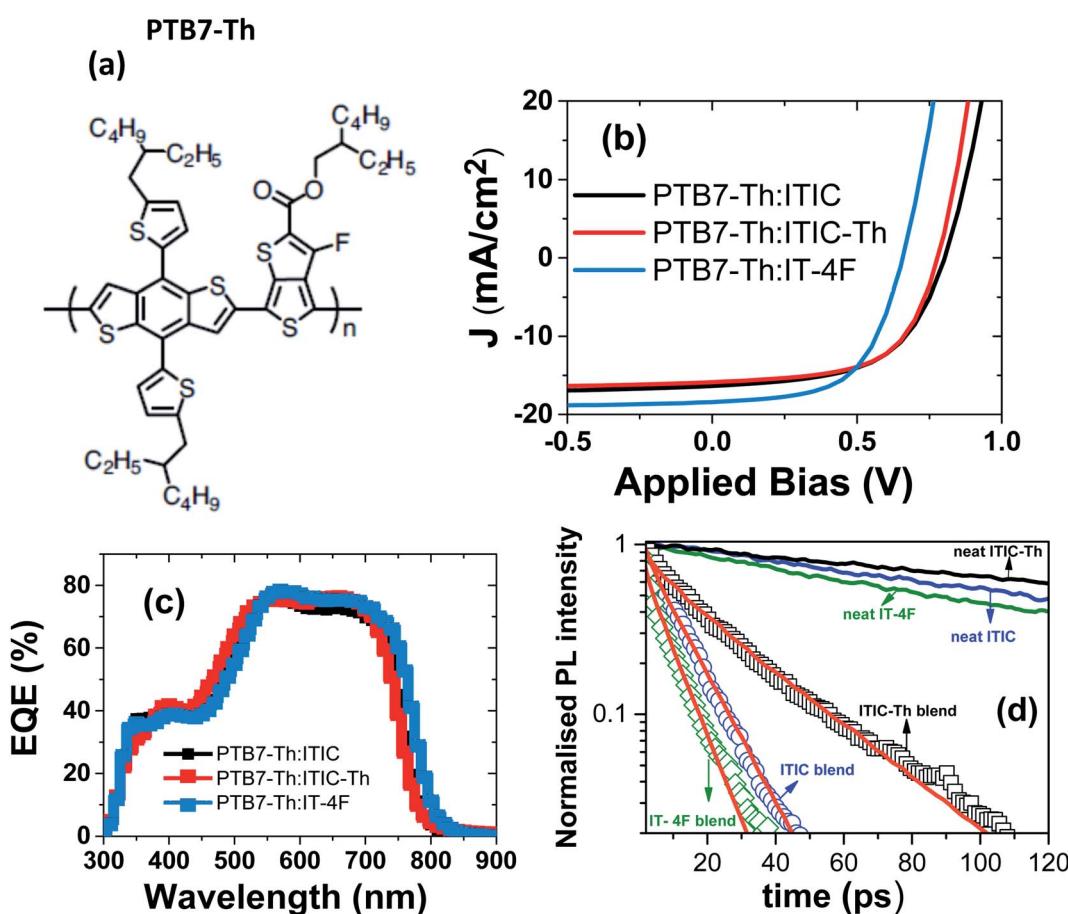


Fig. 4 Device characteristics of PTB7-Th:NFAs (ITIC, ITIC-Th and IT-4F) blends: (a) molecular structure of PTB7-Th, (b) current density–voltage (J – V) curves, (c) external quantum efficiency (EQE) of devices, (d) PL decays in the blends of electron acceptors with PTB7-Th which were used to make solar cells (symbols) and in neat electron acceptor films (solid lines). Solid red lines are the fits using eqn (4) which were used to estimate the average domain sizes of acceptors.

Table 2 Photovoltaic parameters of **PTB7-Th:NFAs**. Φ_{gen} is the charge generation efficiency estimated using fluorescence decay time. The solar cell performance parameters are the average and standard deviation of ten devices

Blend	D : A ratio (wt%)	J_{sc} (mA cm $^{-2}$)	V_{oc} (V)	FF (%)	PCE avg. (%)	PCE best (%)	Domain size (nm)	Φ_{gen}
PTB7-Th:ITIC	1 : 1.3	15.6 ± 0.7	0.789 ± 0.008	54.9 ± 1.7	6.76 ± 0.56	7.38	17 nm	0.91
PTB7-Th:ITIC-Th	1 : 1.3	14.5 ± 0.3	0.773 ± 0.007	62.7 ± 1.9	7.0 ± 0.3	7.45	32 nm	0.90
PTB7-Th:IT-4F	1 : 1.3	17.2 ± 1.1	0.649 ± 0.014	55.6 ± 3.4	6.20 ± 0.51	6.99	14 nm	0.93

the other two blends, the ideality factor (n) was estimated for the three blends. To obtain the value of n , we fitted the I - V curves (Fig. S10†) using the equation below.

$$I = I_{\text{L}} - I_{\text{o}} \exp \frac{q(V + IR_{\text{s}})}{nkT} - \frac{V + IR_{\text{s}}}{R_{\text{sh}}} \quad (3)$$

The values of n obtained are 1.53 ± 0.41 for **PTB7-Th:ITIC**, 1.43 ± 0.34 for **PTB7-Th:ITIC-Th** and 1.55 ± 0.39 for **PTB7-Th:IT-4F**. The n value of the **PTB7-Th:ITIC-Th** blend is lowest, suggesting lower recombination losses in this blend than the other two. For the blends of **PTB7-Th:ITIC** and **PTB7-Th:IT-4F**, the estimated n values are similar and this is in agreement with their similar FF values shown in Table 2. To understand the contribution of mobility in the high FF for the blend with **ITIC-Th**, the electron mobility of the three NFAs was also considered. Previous studies have reported electron mobilities of 1.10×10^{-4} cm 2 V $^{-1}$ s $^{-1}$ for **ITIC**, 6.10×10^{-4} cm 2 V $^{-1}$ s $^{-1}$ for **ITIC-Th**, and 4.37×10^{-4} cm 2 V $^{-1}$ s $^{-1}$ for **IT-4F**.³² The higher electron mobility of **ITIC-Th** NFA compared to the other two will also be contributing to the higher FF for the blend containing this NFA.

The higher FF in the **PTB7-Th:ITIC-Th** blend also indicates improved dissociation of charge transfer states in competition with geminate recombination and better charge extraction. A previous study has established a positive correlation between the device FF, the coherence length of π - π stacking of **ITIC-Th** molecules and electron mobility.³³ We observed a higher exciton diffusion coefficient in **ITIC-Th** films than the other derivatives. It is very likely that exciton diffusivity and electron mobility both increase as a result of the improved coherence length in **ITIC-Th**. Non-geminate recombination is more severe in finely mixed BHJs with large area of the donor-acceptor interface. To investigate this hypothesis we measured the domain size in the blends using time-resolved PL spectroscopy.

We can estimate the average domain size of non-fullerene acceptors assuming that the PL quenching in the blends is limited by exciton diffusion in acceptor domains to the boundary with **PTB7-Th** using a procedure previously described by Hedley *et al.*³¹ and Jagadamma *et al.*³⁵ For this purpose we measured the PL decays in the blends of electron acceptors with **PTB7-Th** which were used to make solar cells and normalised them to the PL decays in neat electron acceptor films to account for the natural exciton decay in non-fullerene acceptors (Fig. 4d). This approach is justified by good agreement of PL spectra measured in the blends and in neat acceptor films which all are substantially red-shifted relative to the **PTB7-Th** spectrum (Fig. S11†). Time-resolved PL spectra of the blends

show a red-shift within 10 ps after excitation which can be attributed to energy transfer from **PTB7-Th** to electron acceptors (Fig. S12†). This suggests that **PTB7-Th** domains are much smaller than L_{3D} in **PTB7-Th** of 12 nm or that these have some admixture of electron acceptor. The AFM image (Fig. S13†) shows that at least on the surface the domains are approximately round rather than elongated, therefore, in order to estimate their size we assumed that they have spherical shape. Previous studies of **PTB7-Th** blends with **ITIC** derivatives deposited by one-step spin-coating also showed fine granular morphology with roughly round grains.^{35,36} Recent reports show that high efficiency can also be achieved in sequentially deposited donor acceptor layers which may have very different needle-like morphology.^{37,38}

Hence, assuming that acceptor domains have a spherical shape with a radius r , the ratio $g(t)$ of the PL decay in a blend to the PL decay in a neat acceptor film is described by

$$g(t) = \frac{6}{\pi^2} \sum_{m=1}^{\infty} \frac{1}{m^2} \exp \left(\frac{-D\pi^2 m^2 t}{r^2} \right) \quad (4)$$

The radius of the sphere r is the only fitting parameter in this case as the exciton diffusion coefficient D was determined for each non-fullerene acceptor in the annihilation and volume quenching measurements described above. For the fitting, eqn (4) was multiplied by the fluorescence intensity in the absence of quencher and then used to fit the PL decays of the blends. A domain size of approximately 17 nm was obtained for **ITIC**, 32 nm for **ITIC-Th** and 14 nm for **IT-4F**. Large domains in the case of **ITIC-Th** are consistent with the higher fill factor observed. These results can be compared to the long-period (domain spacing) which was measured at around 95 nm in **PTB7-Th:ITIC-Th** blend using R-SoXS.³³ Our method gives us a size estimate of pure acceptor domains because any mixture of the donor polymer would give faster PL quenching as compared to quenching solely at the domain boundaries. According to R-SoXS results, the domain purity in **PTB7-Th:ITIC-Th** blend is not the highest among other blends, hence, we consider our findings compatible with the reported R-SoXS results.

However, large domains could limit exciton harvesting as excitons have further to diffuse to a heterojunction. We therefore estimated the charge generation efficiency in these blends using the PL decays in the presence and absence of quencher as $\varphi_{\text{gen}} = 1 - \frac{\tau_{\text{blend}}}{\tau_{\text{neat}}}$, where τ_{blend} is the lifetime of blend and τ_{neat} is the lifetime of neat acceptor film. We made an assumption here that every exciton that is quenched generates a charge. PL



decays of blends and neat films are non-exponential, therefore we used $1/e$ lifetimes for our estimation. A generation efficiency of $\sim 91\%$ was obtained for **ITIC**, $\sim 90\%$ for **ITIC-Th** and $\sim 93\%$ for **IT-4F**. Efficient charge generation (90%) in the blend of **PTB7-Th:ITIC-Th** even with large domains (>30 nm) indicates that most of the photogenerated excitons reach the interface due to large exciton diffusion length (>30 nm).

Conclusions

In conclusion, we measured the exciton diffusion coefficient in a family of fused ring non-fullerene acceptors and found values of exciton diffusion coefficient that are higher than many OPV materials, including fullerene derivatives. Furthermore, we found that exciton diffusion is time-independent, suggesting that there is less energetic and structural disorder in these materials. The high exciton diffusion coefficient leads to three-dimensional diffusion lengths of up to 31 nm, which allow blends with large domain sizes to be made using these NFAs. Our measurement of large exciton diffusion length along with large domains gives further understanding of why NFAs are such attractive materials for organic solar cells.

Experimental section

Absorption measurements

Materials for this study were purchased from 1-Material. The absorption of films were measured using a Cary 300 UV-Vis spectrophotometer. Film thicknesses of 40–50 nm were used for these measurements.

Time-resolved PL measurements

Time-resolved PL decays were measured with Hamamatsu C6860 streak camera in synchroscan mode. In the volume quenching and low excitation density measurements of neat films, the excitation was with 100 fs pulses at an excitation wavelength of 515 nm and a repetition rate of 80 MHz. For exciton-exciton annihilation measurements, the films were excited using 200 fs pulses at 640 nm with 100 kHz repetition rate generated by an optical parametric amplifier pumped by Pharos regenerative amplifier.

For exciton-exciton annihilation measurements films of thickness 40–50 nm were used, so that the excitation density was close to uniform throughout the film. The thickness of photovoltaic blends used in time resolved study was around 100 nm as optimised for the best device efficiency.

For volume quenching measurement, the solutions of NFAs and donor (**DR3TBDTT**) was prepared separately using chlorobenzene and were kept overnight at 60 °C inside the glovebox. These solutions were mixed together and films were made by spin-coating the solution at 2000 rpm for 60 s inside the glovebox.

Device fabrication and characterisation

Inverted organic solar cells were fabricated on pre-patterned ITO-coated glass. The ITO-coated glass substrates were

cleaned in detergent (Hellmanex, Sigma Aldrich), successively ultrasonicated in deionized water, acetone, and isopropyl alcohol, and exposed to an oxygen plasma for 3 minutes. The blend solutions of **PTB7-Th:NFAs** were prepared by dissolving the components in a ratio of 1 : 1.3 (by weight), with a total concentration of 23 mg mL⁻¹ in chlorobenzene. The solution was kept stirring at 60 °C for ~ 8 hours before spin-coating.

In all the inverted organic solar cells fabricated, the electron transporting layer was amorphous ZnO (a-ZnO) thin film having a thickness of ~ 25 nm and was prepared according to a previous report.³⁹ The active layer was deposited by spin-coating (at 1500 rpm for 45 s) on glass/ITO/a-ZnO substrates inside a nitrogen filled glove box. The samples were then transferred to a thermal evaporator (1×10^{-6} mbar base pressure) in the glove box and the hole transporting layer of MoO_x (7 nm) and anode Ag (100 nm) deposited through a shadow mask. The active area of the device was 0.07 cm².

After the electrode deposition, the devices were encapsulated with an UV optical adhesive and a glass coverslip. The current-voltage characteristics were determined under an illumination intensity of 100 mW cm⁻² in air using an air mass 1.5 global (AM 1.5 G) Scientech solar simulator and a Keithley 2400 source-measure unit. The illumination intensity was verified with a calibrated mono-silicon detector and a KG-5 filter. The external quantum efficiency (EQE) measurements were performed at zero bias by illuminating the device with monochromatic light supplied from a xenon arc lamp in combination with a Bentham TMc300 monochromator. The number of photons incident on the sample was calculated for each wavelength by using a silicon photodiode calibrated by the National Physical Laboratory (NPL).

Conflicts of interest

There are no conflicts to declare.

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Notes and references

- 1 J. Hou, O. Inganäs, R. H. Friend and F. Gao, *Nat. Mater.*, 2018, **17**, 119–128.
- 2 P. Cheng, G. Li, X. Zhan and Y. Yang, *Nat. Photonics*, 2018, **12**, 131–142.
- 3 C. Yan, S. Barlow, Z. Wang, H. Yan, A. K.-Y. Jen, S. R. Marder and X. Zhan, *Nat. Rev. Mater.*, 2018, **3**, 1–19.
- 4 Y. Lin, B. Adilbekova, Y. Firdaus, E. Yengel, H. Faber, M. Sajjad, X. Zheng, E. Yarali, A. Seitkhan, O. M. Bakr, A. El-Labban, U. Schwingenschlögl, V. Tung, I. McCulloch, F. Laquai and T. D. Anthopoulos, *Adv. Mater.*, 2019, **31**, 1902965.



5 Y. Cui, H. Yao, J. Zhang, K. Xian, T. Zhang, L. Hong, Y. Wang, Y. Xu, K. Ma and C. An, *Adv. Mater.*, 2020, **32**, 1908205.

6 X. Xu, J. Xiao, G. Zhang, L. Wei, X. Jiao, H.-L. Yip and Y. Cao, *Sci. Bull.*, 2020, **65**, 208–216.

7 S. B. Darling and F. You, *RSC Adv.*, 2013, **3**, 17633–17648.

8 J. Lee, S.-J. Ko, H. Lee, J. Huang, Z. Zhu, M. Seifrid, J. Vollbrecht, V. V. Brus, A. Karki and H. Wang, *ACS Energy Lett.*, 2019, **4**, 1401–1409.

9 V. V. Brus, J. Lee, B. R. Luginbuhl, S. J. Ko, G. C. Bazan and T. Q. Nguyen, *Adv. Mater.*, 2019, **31**, 1900904.

10 G. J. Hedley, A. Ruseckas and I. D. W. Samuel, *Chem. Rev.*, 2017, **117**, 796–837.

11 O. V. Mikhnenco, P. W. Blom and T.-Q. Nguyen, *Energy Environ. Sci.*, 2015, **8**, 1867–1888.

12 Y. Lin, F. Zhao, S. K. Prasad, J. D. Chen, W. Cai, Q. Zhang, K. Chen, Y. Wu, W. Ma, F. Gao, J.-X. Tang, C. Wang, W. You, J. M. Hodgkiss and X. Zhan, *Adv. Mater.*, 2018, **30**, 1706363.

13 S. Chandrasebose, K. Chen, A. J. Barker, J. J. Sutton, S. K. Prasad, J. Zhu, J. Zhou, K. C. Gordon, Z. Xie, X. Zhan and J. M. Hodgkiss, *J. Am. Chem. Soc.*, 2019, **141**, 6922–6929.

14 S. Dai, J. Zhou, S. Chandrasebose, Y. Shi, G. Han, K. Chen, J. Xin, K. Liu, Z. Chen, Z. Xie, W. Ma, Y. Yi, L. Jiang, J. M. Hodgkiss and X. Zhan, *Adv. Mater.*, 2020, **32**, 2000645.

15 Y. Lin, J. Wang, Z. G. Zhang, H. Bai, Y. Li, D. Zhu and X. Zhan, *Adv. Mater.*, 2015, **27**, 1170–1174.

16 Y. Lin, F. Zhao, Q. He, L. Huo, Y. Wu, T. C. Parker, W. Ma, Y. Sun, C. Wang, D. Zhu, A. J. Heeger, S. R. Marder and X. Zhan, *J. Am. Chem. Soc.*, 2016, **138**, 4955–4961.

17 W. Zhao, S. Li, H. Yao, S. Zhang, Y. Zhang, B. Yang and J. Hou, *J. Am. Chem. Soc.*, 2017, **139**, 7148–7151.

18 R. S. Gurney, W. Li, Y. Yan, D. Liu, A. J. Pearson and T. Wang, *J. Energy Chem.*, 2019, **37**, 148–156.

19 A. J. Ward, A. Ruseckas and I. D. W. Samuel, *J. Phys. Chem. C*, 2012, **116**, 23931–23937.

20 M. T. Sajjad, A. J. Ward, A. Ruseckas, A. K. Bansal, S. Allard, U. Scherf and I. D. W. Samuel, *Phys. Status Solidi RRL*, 2019, **13**, 1800500.

21 U. Gösele, M. Hauser, U. Klein and R. Frey, *Chem. Phys. Lett.*, 1975, **34**, 519–522.

22 U. Klein, R. Frey, M. Hauser and U. Gösele, *Chem. Phys. Lett.*, 1976, **41**, 139–142.

23 R. Kepler, V. Valencia, S. Jacobs and J. McNamara, *Synth. Met.*, 1996, **78**, 227–230.

24 A. Ruseckas, M. Theander, L. Valkunas, M. Andersson, O. Inganäs and V. Sundström, *J. Lumin.*, 1998, **76**, 474–477.

25 M. A. Stevens, C. Silva, D. M. Russell and R. H. Friend, *Phys. Rev. B*, 2001, **63**, 165213.

26 M. T. Sajjad, O. Blaszczyk, L. K. Jagadamma, T. J. Roland, M. Chowdhury, A. Ruseckas and I. D. W. Samuel, *J. Mater. Chem. A*, 2018, **6**, 9445–9450.

27 M. T. Sajjad, Y. Zhang, P. B. Geraghty, V. D. Mitchell, A. Ruseckas, O. Blaszczyk, D. J. Jones and I. D. W. Samuel, *J. Mater. Chem. C*, 2019, **7**, 7922–7928.

28 P. E. Shaw, A. Ruseckas and I. D. W. Samuel, *Adv. Mater.*, 2008, **20**, 3516–3520.

29 J. Mai, Y. Xiao, G. Zhou, J. Wang, J. Zhu, N. Zhao, X. Zhan and X. Lu, *Adv. Mater.*, 2018, **30**, 1802888.

30 R. Ma, Y. Chen, T. Liu, Y. Xiao, Z. Luo, M. Zhang, S. Luo, X. Lu, G. Zhang, Y. Li, H. Yan and K. Chen, *J. Mater. Chem. C*, 2020, **8**, 909–915.

31 G. J. Hedley, A. J. Ward, A. Alekseev, C. T. Howells, E. R. Martins, L. A. Serrano, G. Cooke, A. Ruseckas and I. D. W. Samuel, *Nat. Commun.*, 2013, **4**, 2867.

32 A. Wadsworth, M. Moser, A. Marks, M. S. Little, N. Gasparini, C. J. Brabec, D. Baran and I. McCulloch, *Chem. Soc. Rev.*, 2019, **48**, 1596–1625.

33 H. Hu, K. Jiang, P. C. Chow, L. Ye, G. Zhang, Z. Li, J. H. Carpenter, H. Ade and H. Yan, *Adv. Energy Mater.*, 2018, **8**, 1701674.

34 M. T. Sajjad, A. J. Ward, C. Kastner, A. Ruseckas, H. Hoppe and I. D. W. Samuel, *J. Phys. Chem. Lett.*, 2015, **6**, 3054–3060.

35 L. K. Jagadamma, M. T. Sajjad, V. Savikhin, M. F. Toney and I. D. W. Samuel, *J. Mater. Chem. A*, 2017, **5**, 14646–14657.

36 Y. Tang, H. Sun, Z. Wu, Y. Zhang, G. Zhang, M. Su, X. Zhou, X. Wu, W. Sun, X. Zhang, B. Liu, W. Chen, Q. Liao, H. Y. Woo and X. Guo, *Adv. Sci.*, 2019, **6**, 1901773.

37 R. Sun, J. Guo, Q. Wu, Z. Zhang, W. Yang, J. Guo, M. Shi, Y. Zhang, S. Kahmann, L. Ye, X. Jiao, M. A. Loi, Q. Shen, H. Ade, W. Tang, C. J. Brabec and J. Min, *Energy Environ. Sci.*, 2019, **12**, 3118–3132.

38 L. Ye, Y. Xiong, Z. Chen, Q. Zhang, Z. Fei, R. Henry, M. Heeney, B. T. O'Connor, W. You and H. Ade, *Adv. Mater.*, 2019, **31**, 1808153.

39 L. K. Jagadamma, M. Abdelsamie, A. El Labban, E. Aresu, G. O. N. Ndjawa, D. H. Anjum, D. Cha, P. M. Beaujuge and A. Amassian, *J. Mater. Chem. A*, 2014, **2**, 13321–13331.

40 M. T. Sajjad, A. Ruseckas, L. K. Jagadamma, Y. Zhang and I. D. W. Samuel, *Dataset*, University of St Andrews Research Portal, 2020, DOI: 10.17630/7bfdb2ad-def7-482b-82a8-4756b0d029c1.

